

**N-Channel MOSFET** 

## **General Description**

The WSL65R028F is the highest performance Trench N-Channel MOSFET with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSL160N20 meet the RoHS and Green Product requirement, 100%  $E_{AS}$  guaranteed with full function reliability approved.

#### **Features**

- 100% UIS + R<sub>g</sub> Tested.
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

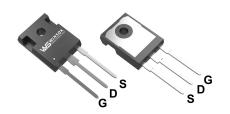
## **Product Summery**

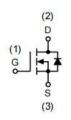
BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub>
200V	9.5mΩ	160A

### **Applications**

- Power Management for Industrial DC/DC Converters
- Uninterruptible Power Supply

## **TO-247-3L Pin Configuration**





# **Absolute Maximum Ratings** (T<sub>A</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter		Rating	Units	
V <sub>DS</sub>	Drain-Source Voltage		200	.,	
V <sub>GS</sub>	Gate-Source Voltage		±20	V	
. 7	Continuous Drain Current	T <sub>C</sub> =25°C	160		
I <sub>D</sub> <sup>7</sup>		T <sub>C</sub> =100°C	95	Α	
I <sub>DM</sub> <sup>3</sup>	Pulse Drain Current		531		
D 2	Power Dissipation	T <sub>C</sub> =25°C	530	W	
P <sub>D</sub> <sup>2</sup>		T <sub>C</sub> =100°C	310	VV	
I <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Current		200	Α	
E <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Energy L=10mH		1360	mJ	
T <sub>STG</sub>	Storage Temperature Range		-55 to 150	°C	
TJ	Operating Junction Temperature Range		-55 to 150		
D 14	Thermal Resistance-Junction to Ambient	t≤10s	35		
R <sub>θJA</sub> <sup>1,4</sup>		Steady State	45	°C/W	
R <sub>eJC</sub>	Thermal Resistance-Junction to Case		0.24		



## Electrical Characteristics (T<sub>J</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250μA	200			V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =30A		9.5	11.5	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_{D}=250\mu A$	3.5	4.5	5.0	V
	Drain Source Leakage Current	V <sub>DS</sub> =200V , V <sub>GS</sub> =0V			1.0	
I <sub>DSS</sub>	Drain-Source Leakage Current	T <sub>J</sub> =55°C			100	μΑ
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{DS}$ =0V , $V_{GS}$ =±20V			±100	nA
9 <sub>fs</sub>	Forward Transconductance	$V_{DS}$ =25V , $I_{D}$ =40A		70		S
$R_G$	Gate Resistance	f=1.0MHz		1.3		Ω
$Q_g$	Total Gate Charge (10V)			85		
$Q_g$	Total Gate Charge (4.5V)	V =100V V =10V L=20A		66		nC
$Q_{gs}$	Gate-Source Charge	$V_{DS}$ =100V , $V_{GS}$ =10V , $I_{D}$ =80A		15		IIC
$Q_{gd}$	Gate-Drain Charge			25		
T <sub>d(on)</sub>	Turn-On Delay Time			45		
T <sub>r</sub>	Rise Time	$V_{DS} = 100 V$ , $V_{GS} = 10 V$ , $I_{D} = 80 A$		70		
T <sub>d(off)</sub>	Turn-Off Delay Time	$R_L=1\Omega$ , $R_{GEN}=6\Omega$		110		ns
T <sub>f</sub>	Fall Time	92.1		90		
C <sub>iss</sub>	Input Capacitance			12000		
C <sub>oss</sub>	Output Capacitance	$V_{DS}$ =25V , $V_{GS}$ =0V , $f$ =1.0MHz		550		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			300		

### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
I <sub>S</sub> <sup>7</sup>	Continuous Source Current				160	Α
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =80A		0.9	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	L = 20 A di/dt=100 A/vo		110		ns
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> =30A , di/dt=100A/μs		698		nC

#### Note:

- The value of R<sub>θJA</sub> is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> t≤ 10s and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- 2. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 3. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =150°C.
- 4. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- 5. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.
- 6. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.
- 7. The maximum current rating is package limited.
- 8. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.
- 9. The maximum current rating is silicon limited



## **Typical Characteristics**

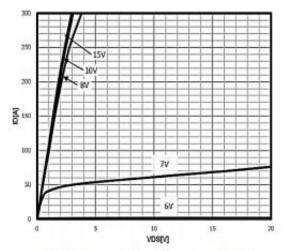


Figure1:Typ output characteristics

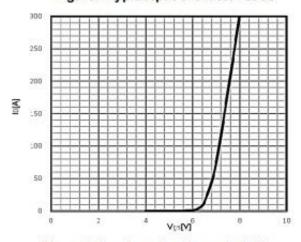


Figure3:Typ. transfer characteristics

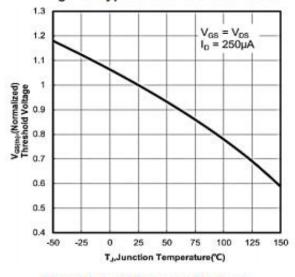


Figure5: Gate Threshold Voltage

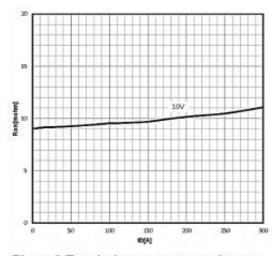


Figure2:Typ drain-source on resistance

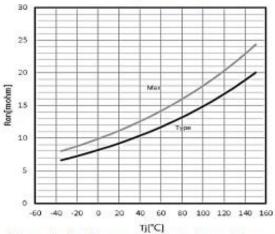


Figure4: Drain-source on-state resistance

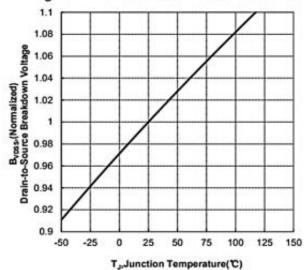
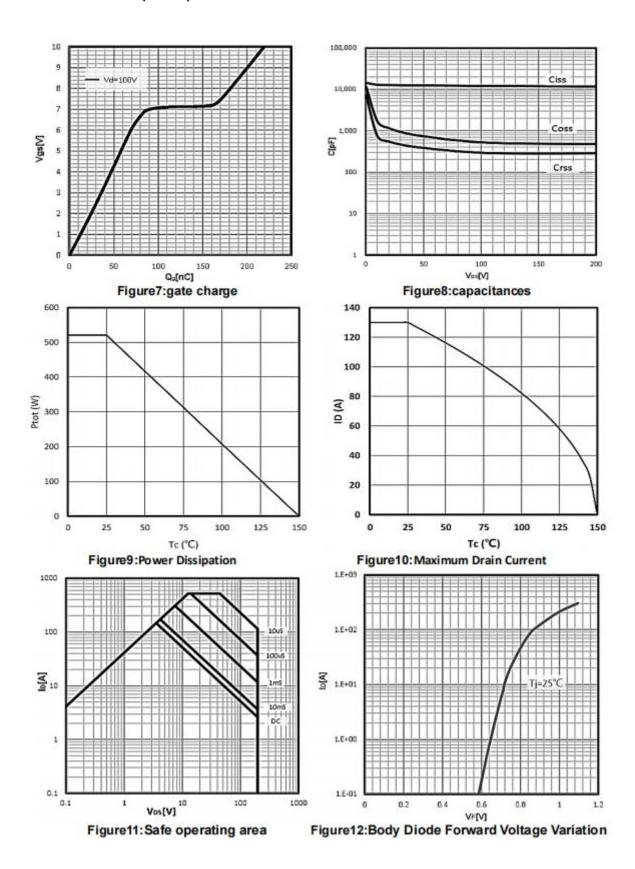


Figure6: Drain-source breakdown voltage

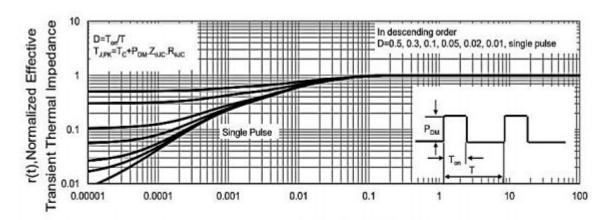


## **Typical Characteristics (Cont.)**





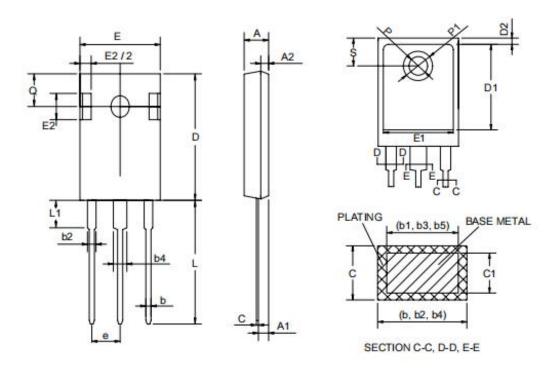
## **Typical Characteristics (Cont.)**



Square Wave Pluse Duration(sec)
Figure 13: Max. transient thermal impedance

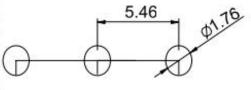


## **Packaging information**



ş		TO	-247	
SM -	MILLIMETERS		INCH	HES
	MIN.	MAX.	MIN.	MAX.
Α	4.7	5.31	0.185	0.209
A1	2.21	2.59	0.087	0.102
A2	1.5	2.49	0.059	0.098
D	20.8	21.46	0.819	0.845
E	15.49	16.26	0.610	0.640
E2	4.32	5.49	0.170	0.216
е	5.46	BSC	0.215	BSC
L	19.81	20.32	0.780	0.800
L1	-	4.5	11-2	0.177
P	3.56	3.66	0.140	0.144
Q	5.38	6.2	0.212	0.244
S	6.15	BSC	0.242	BSC
b	0.99	1.4	0.039	0.055
b1	0.99	1.35	0.039	0.053
b2	1.65	2.39	0.065	0.094
b3	1.65	2.34	0.065	0.092
b4	2.59	3.43	0.102	0.135
b5	2.59	3.38	0.102	0.133
C	0.38	0.89	0.015	0.035
c1	0.38	0.84	0.015	0.033
D1	13.08	-	0.515	-
D2	0.51	1.35	0.020	0.053
E1	13.46		0.530	1,5
P1		7.4	-	0.291

## RECOMMENDED LAND PATTERN



UNIT: mm





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